

Search Notes

Application/Control No.

10/654,770

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

PARK ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	696	11/14/2005	BT
438	700	11/14/2005	BT
438	710	11/14/2005	BT
438	718	11/14/2005	BT

INTERFERENCE SEARCHED

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438	696	11/14/2005	
438	700	11/14/2005	
438	710	11/14/2005	
438/718		11/14/2005	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update search using EAST	11/14/2005	BT